CeraDiodes

High-speed series

Series/Type:

Date: April 2016

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CeraDiodes

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EPCOS type designation

CD	S	2	C05	GTA

CD ≙ CeraDiode

Device
S ≙ Single device
A ≙ Array device

Case sizes of single devices

Code	Case size (inch/mm)
1	0201/0603
2	0402/1005
3	0603/1608
4	1003/2508

Case sizes of array devices

Code	Case size (inch/mm)
3	0506/1216
4	0508/1220
5	0612/1632
6	1012/2532

Rated voltage

Code	VDC
040	4
050	5.5/ 5.6
090	9
120	12
150	15
160	16
180	18
200	20/ 22
300	30
360	36
480	48
700	70
900	90
201	200

Type
GTA ≙ Standard
GTB ≙ LED
GTH ≙ High-speed
HDMI1 ≙ Capacitance value <1 pF
HDMI2 ≙ Capacitance value <1 pF

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Ordering code system

B72590	D	0050	A0	60

Type, case sizes and device

Chip size (inch/mm)	Device	Ordering code
0201/0603	Single	B72440...
0402/1005	Single	B72590...
0603/1608	Single	B72500...
1003/2508	Single	B72570...
0506/1216	Array	B72755...
0508/1220	Array	B72714...
0612/1632	Array	B72724...
1012/2532	Array	B72735...

D ≙ CeraDiode

Rated voltage

Code	VDC
0040	4
0050	5.5/ 5.6
0090	9
0120	12
0150	15
0160	16
0180	18
0200	20/ 22
0300	30
0360	36
0480	48
0700	70
0900	90
0201	200

Type
A0 ≙ Standard
B0 ≙ LED
H0 ≙ High-speed
H1 ≙ Capacitance value <1 pF
H2 ≙ Capacitance value <1 pF

Packaging
60 ≙ Cardboard tape, 180-mm reel
62 ≙ Blister tape, 180-mm reel
70 ≙ Cardboard tape, 330-mm reel
72 ≙ Blister tape, 330-mm reel

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Single chip

4-fold array

2/4 data + 1 supply

Features

- Very low capacitance values 0.6 up to 10 pF
- ESD protection to IEC 61000-4-2, level 4
- Bidirectional ESD protection in one component
- No change in ESD protection performance at temperatures up to 85 °C (temperature derating)
- Low parasitic inductance
- Low leakage current
- Fast response time <0.5 ns
- Lead-free nickel barrier terminations suitable for lead-free soldering
- RoHS-compatible

Applications

- Interfaces, data lines (USB, IEEE 1394, Ethernet, parallel port, SATA, DisplayPort, etc.), audio lines (digital) and video lines (analog), DVI, HDMI, ICs and I/O ports
- Consumer electronic products (TV, DVD player/recorder, set-top box, game consoles, MP3 player, digital still/video camera, etc.)
- EDP products (desktop and notebook computer, monitor, PDA, printer, memory card, control unit, head set, speaker, HDD, optical drive, etc.)
- Industrial applications
- Mobile phone applications

Design

- Multilayer technology
- Nickel barrier termination (Ag/Ni/Sn) for lead-free soldering

Marking

- Due to the symmetrical configuration no marking information is needed.

General technical data

Maximum DC operating voltage		$V_{DC,max}$	5.5 ... 30	V
Typical capacitance		C_{typ}	0.6 ... 10	pF
Air discharge ESD capability	to IEC 61000-4-2	$V_{ESD,air}$	15	kV
Contact discharge ESD capability	to IEC 61000-4-2	$V_{ESD,contact}$	8	kV
Leakage current	(V_{leak} = 5.6 V)	I_{leak}	1	µA
Operating temperature		T_{op}	−40/+85	°C
Storage temperature		LCT/UCT	−40/+125	°C

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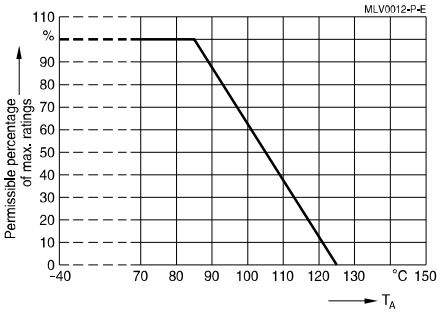
Electrical specifications and ordering codes

Maximum ratings ($T_{op,max}$ = 85 °C) and characteristics (T_A = 25 °C)

Type	Ordering code	$V_{DC,max}$ V	$V_{BR,min}$ (1 mA) V	$V_{clamp,max}$ (1 A) V	C_{typ} (1 MHz, 1 V) pF	C_{max} (1 MHz, 1 V) pF
Array, 2/4 data + 1 supply, 0506, SOT-666						
CDA3C05GTH	B72755D0050H062	5.6	106	395	2.2	3.5
Array, 2/4 data + 1 supply, 1012, SOT-23 6L						
CDA6C05GTH	B72735D0050H062	5.6	52	195	7	10
Array, 4-fold, 0508, no semiconductor diode equivalent						
CDA4C16GTH	B72714D0160H060	16	22	66	10	15
Array, 4-fold, 0612, no semiconductor diode equivalent						
CDA5C16GTH	B72724D0160H062	16	80	350	3	5
Single, 0201, no semiconductor diode equivalent						
CDS1C05GTH1	B72440C0050H160	5.5	17	33	7	-
CDS1C05GTH2	B72440C0050H260	5.5	20	66	3	-
Single, 0402, SOD-723						
CDS2C05HDMI1	B72590D0050H160	5.6	150	-	0.6	0.9
CDS2C05HDMI2	B72590D0050H260	5.6	90	-	0.6	0.9
CDS2C12GTH	B72590D0120H060	12	20	66	4.5	-
CDS2C15GTH	B72590D0150H060	15	23	66	10	15
CDS2C16GTH	B72590D0160H060	16	65	290	2	3
CDS2C20GTH	B72590D0200H060	20	30	80	10	13
Single, 0603, SOD-523						
CDS3C05HDMI1	B72500D0050H160	5.6	150	-	0.6	0.9
CDS3C16GTH	B72500D0160H060	16	65	290	3	5
CDS3C30GTH	B72500D0300H060	30	50	120	10	15
Single, 1003, SOD-323						
CDS4C16GTH	B72570D0160H060	16	38	146	3	5

Typical characteristics



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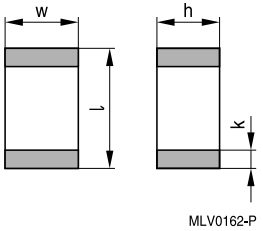
Dimensional drawings

Single device

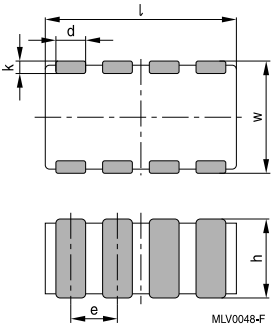


Dimensions in mm

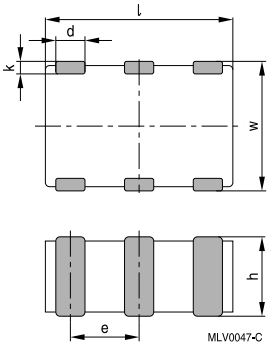
Case (inch) / size (mm)	0201 / 0603		0402 / 1005		0603 / 1608		1003 / 2508	
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
l	0.57	0.63	0.85	1.15	1.45	1.75	2.34	2.74
w	0.27	0.33	0.4	0.6	0.7	0.9	0.7	0.9
h	0.27	0.33	0.4	0.6	0.7	0.9	0.7	0.9
k	0.1	0.2	0.1	0.3	0.1	0.4	0.13	0.75

Array devices

4-fold array



2/4 data + 1 supply



Dimension in mm

Case size (inch) / (mm)	0506 / 1216		0508 / 1220		0612 / 1632		1012 / 2532	
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
l	1.50	1.70	1.8	2.2	3.0	3.4	2.90	3.50
w	1.20	1.40	1.05	1.45	1.45	1.75	2.25	2.75
h	-	0.6	-	0.9	-	0.9	-	1.2
d	0.2	0.4	0.2	0.4	0.25	0.55	0.35	0.65
e	0.4	0.6	0.4	0.6	0.61	0.91	0.8	1.1
k	-	0.35	-	0.35	-	0.35	-	0.45

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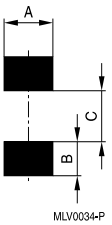
Recommended solder pads

Single device

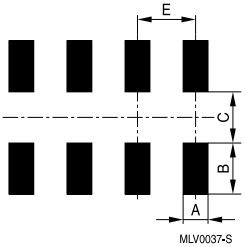


Dimensions in mm

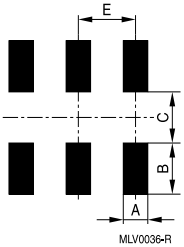
Case size (inch) / (mm)	0201 / 0603	0402 / 1005	0603 / 1608	1003 / 2508
A	0.3	0.6	1.0	0.8
B	0.25	0.6	1.0	0.8
C	0.3	0.5	1.0	1.45

Array devices

4-fold array



2/4 data + 1 supply



Dimensions in mm

Case size (inch) / (mm)	0506 / 1216	0508 / 1220	0612 / 1632	1012 / 2532
A	0.36	0.35	0.5	0.7
B	0.84	0.9	0.7	1.0
C	0.62	0.4	1.2	1.4
E	0.50	0.5	0.76	0.95

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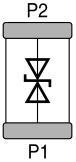
Pin configurations

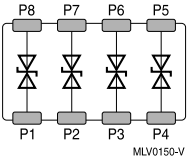
Single device



Pin	Description
P1	GND
P2	I/O line

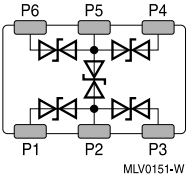
Array devices

4-fold array



Pin	Description
P1	GND
P2	GND
P3	GND
P4	GND
P5	I/O line 1
P6	I/O line 2
P7	I/O line 3
P8	I/O line 4

2/4 data + 1 supply



Pin	Description
P1	I/O line 1
P2	GND
P3	I/O line 2
P4	I/O line 3
P5	V_{DC}
P6	I/O line 4

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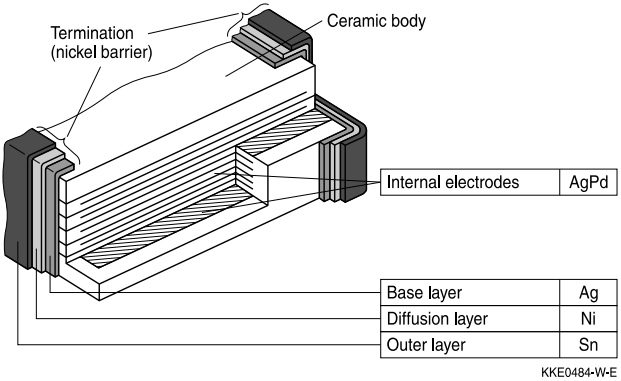
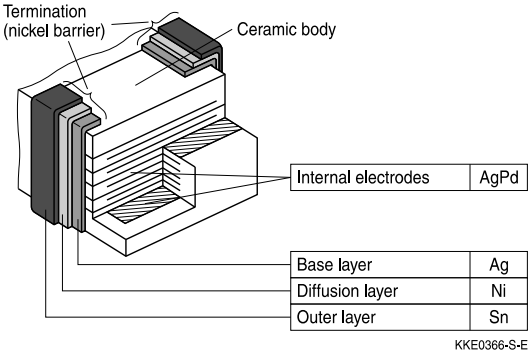
Termination

Single device



KKE0484-W-E

Array device



KKE0366-S-E

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Delivery mode

EIA case size	Taping	Reel size mm	Packing unit pcs.	Type	Ordering code
0201	Cardboard	180	15000	CDS1C05GTH1	B72440C0050H160
0201	Cardboard	180	15000	CDS1C05GTH2	B72440C0050H260
0402	Cardboard	180	10000	CDS2C05HDMI1	B72590D0050H160
0402	Cardboard	180	10000	CDS2C05HDMI2	B72590D0050H260
0402	Cardboard	180	10000	CDS2C12GTH	B72590D0120H060
0402	Cardboard	180	10000	CDS2C15GTH	B72590D0150H060
0402	Cardboard	180	10000	CDS2C16GTH	B72590D0160H060
0402	Cardboard	180	10000	CDS2C20GTH	B72590D0200H060
0506	Blister	180	3000	CDA3C05GTH	B72755D0050H062
0508	Cardboard	180	4000	CDA4C16GTH	B72714D0160H060
0603	Cardboard	180	4000	CDS3C05HDMI1	B72500D0050H160
0603	Cardboard	180	4000	CDS3C16GTH	B72500D0160H060
0603	Cardboard	180	4000	CDS3C30GTH	B72500D0300H060
0612	Blister	180	3000	CDA5C16GTH	B72724D0160H062
1003	Cardboard	180	4000	CDS4C16GTH	B72570D0160H060
1012	Blister	180	2000	CDA6C05GTH	B72735D0050H062

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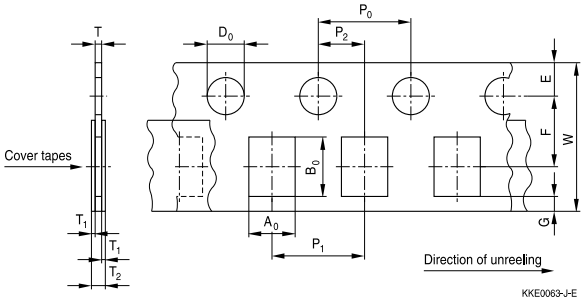
1 Taping and packing for chip and array CeraDiodes

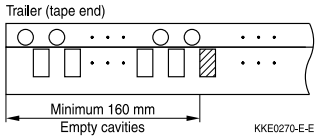
1.1 Cardboard tape (taping to IEC 60286-3)

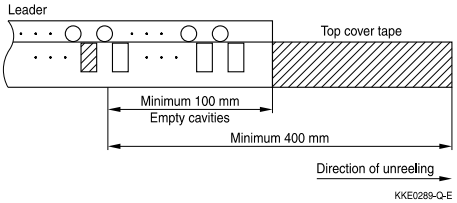


Dimensions in mm

Case size (inch) (mm)		0201 0603	0402 1005	0603 1608	1003 2508	0508 1220	Tolerance
Compartment width	A_0	0.38 ±0.05	0.6	0.95	1.0	1.6	±0.2
Compartment length	B_0	0.68 ±0.05	1.15	1.8	2.85	2.4	±0.2
Sprocket hole diameter	D_0	1.5 ±0.1	1.5	1.5	1.5	1.5	+0.1/ −0
Sprocket hole pitch	P_0	4.0 ±0.1[1)]	4.0	4.0	4.0	4.0	±0.1[1)]
Distance center hole to center compartment	P_2	2.0 ±0.05	2.0	2.0	2.0	2.0	±0.05
Pitch of component compartments	P_1	2.0 ±0.05	2.0	4.0	4.0	4.0	±0.1
Tape width	W	8.0 ±0.3	8.0	8.0	8.0	8.0	±0.3
Distance edge to center of hole	E	1.75 ±0.1	1.75	1.75	1.75	1.75	±0.1
Distance center hole to center compartment	F	3.5 ±0.05	3.5	3.5	3.5	3.5	±0.05
Distance compartment to edge	G	0.75 min.	0.75	0.75	0.75	0.75	min.
Thickness tape	T	0.42 ±0.02	0.6	0.9	0.95	0.95	max.
Overall thickness	T_2	0.4 min.	0.7	1.1	1.1	1.10	max.

[1)] ≤ ±0.2 mm over 10 sprocket holes





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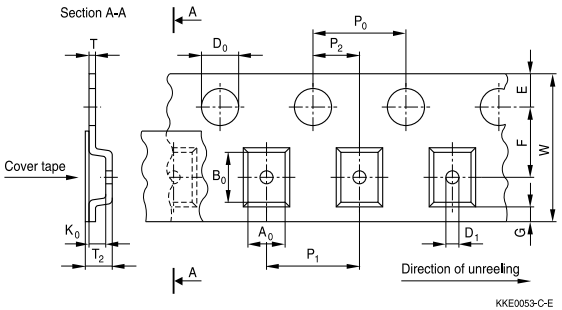
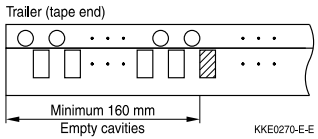
1.2 Blister tape (taping to IEC 60286-3)

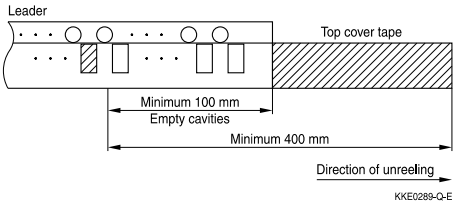


Dimensions in mm

Case size (inch) (mm)		0506 1216	0612 1632	1012 2532	Tolerance
Compartment width	A_0	1.5	1.8	2.8	±0.2
Compartment length	B_0	1.8	3.4	3.5	±0.2
Compartment height	K_0	0.8	1.8	1.8	max.
Sprocket hole diameter	D_0	1.5	1.5	1.5	+0.1/ −0
Compartment hole diameter	D_1	0.3	0.3	0.3	min.
Sprocket hole pitch	P_0	4.0	4.0	4.0	±0.1[1)]
Distance center hole to center compartment	P_2	2.0	2.0	2.0	±0.05
Pitch of component compartments	P_1	4.0	4.0	4.0	±0.1
Tape width	W	8.0	8.0	8.0	±0.3
Distance edge to center of hole	E	1.75	1.75	1.75	±0.1
Distance center hole to center compartment	F	3.5	3.5	3.5	±0.05
Distance compartment to edge	G	0.75	0.75	0.75	min.
Thickness tape	T	0.3	0.3	0.3	max.
Overall thickness	T_2	1.3	2.5	2.5	max.

[1)] ≤ ±0.2 mm over 10 sprocket holes





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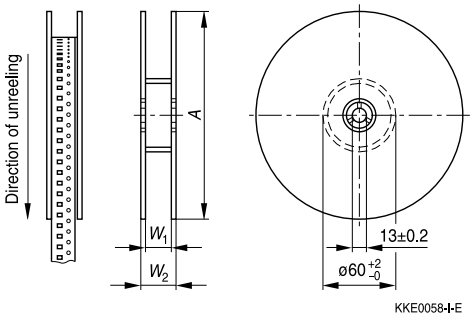
1.3 Reel packing



Dimensions in mm

		Dimensions	Tolerance	Dimensions	Tolerance
Reel diameter	A	180	+0/ –3	330	+0/ –2
Reel width (inside)	W_1	8.4	+1.5/ –0	8.4	+1.5/ –0
Reel width (outside)	W_2	14.4	max.	14.4	max.

Package: 8-mm tape
Reel material: Plastic

1.4 Packing units

Case size (inch) / (mm)	∅ 180-mm reel pieces	∅ 330-mm reel pieces	Tape
0201 / 0603	15000	-	cardboard
0402 / 1005	10000	50000	cardboard
0603 / 1608	4000	16000	cardboard
1003 / 2508	4000	16000	cardboard
0506 / 1216	3000	12000	blister
0508 / 1220	4000	16000	cardboard
0612 / 1632	3000	12000	blister
1012 / 2532	2000	8000	blister

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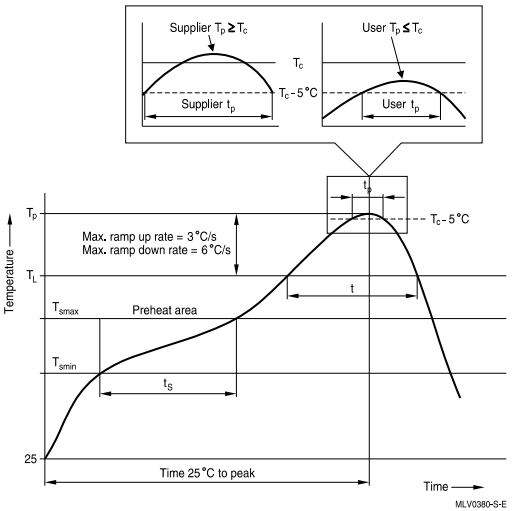
Soldering directions

1 Reflow soldering temperature profile

Recommended temperature characteristic for reflow soldering following JEDEC J-STD-020D



Profile feature		Sn-Pb eutectic assembly	Pb-free assembly
Preheat and soak			
- Temperature min	T_{smin}	100 °C	150 °C
- Temperature max	T_{smax}	150 °C	200 °C
- Time	t_{smin} to t_{smax}	60 ... 120 s	60 ... 180 s
Average ramp-up rate	T_{smax} to T_p	3 °C/ s max.	3 °C/ s max.
Liquidous temperature	T_L	183 °C	217 °C
Time at liquidous	t_L	60 ... 150 s	60 ... 150 s
Peak package body temperature	T_p [1)]	220 °C ... 235 °C [2)]	245 °C ... 260 °C [2)]
Time (t_P) [3)] within 5 °C of specified classification temperature (T_c)		20 s [3)]	30 s [3)]
Average ramp-down rate	T_p to T_{smax}	6 °C/ s max.	6 °C/ s max.
Time 25 °C to peak temperature		maximum 6 min	maximum 8 min

1) Tolerance for peak profile temperature (T_P) is defined as a supplier minimum and a user maximum.
2) Depending on package thickness. For details please refer to JEDEC J-STD-020D.
3) Tolerance for time at peak profile temperature (t_P) is defined as a supplier minimum and a user maximum.

Note: All temperatures refer to topside of the package, measured on the package body surface. Number of reflow cycles: 3

2 Soldering guidelines

The use of mild, non-activated fluxes for soldering is recommended, as well as proper cleaning of the PCB.

The components are suitable for reflow soldering to JEDEC J-STD-020D.

3 Solder joint profiles / solder quantity

3.1 Cement quantity

The component is fixed onto the circuit board with cement prior to soldering. It must still be able to move slightly. When the board is placed into the reflow oven, excessively rigid fixing can lead to high forces acting on the component and thus to a break. In addition, too much cement can lead to unsymmetrical stressing and thus to mechanical fracture of the component. The cement must also be so soft during mounting that no mechanical stressing occurs.

3.2 Mounting the components on the board

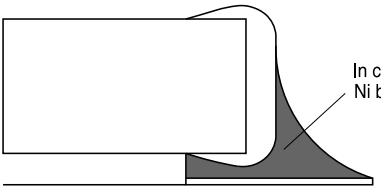
It is best to mount the components on the board before soldering so that one termination does not enter the oven first and the second termination is soldered subsequently. The ideal case is simultaneous wetting of both terminations.

3.3 Solder joint profiles

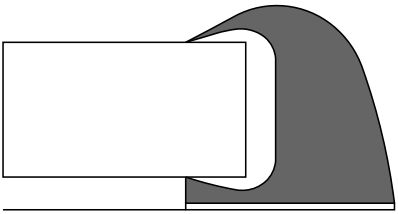
If the meniscus height is too low, that means the solder quantity is too low, the solder joint may break, i.e. the component becomes detached from the joint. This problem is sometimes interpreted as leaching of the external terminations.

If the solder meniscus is too high, i.e. the solder quantity is too large, the vise effect may occur. As the solder cools down, the solder contracts in the direction of the component. If there is too much solder on the component, it has no leeway to evade the stress and may break, as in a vise.

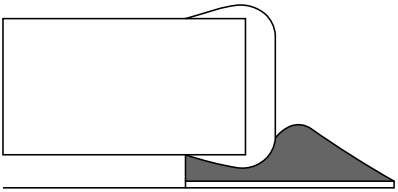
3.3.1 Solder joint profiles for nickel barrier termination



Good solder joint MLV0196-B-E



Too much solder
Pad geometry too large KKE0071-A-E



Poor wetting KKE0072-I-E

Good and poor solder joints caused by amount of solder in infrared reflow soldering

4 Solderability tests

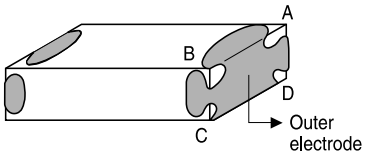
Test	Standard	Test conditions / Sn-Pb soldering	Test conditions / Pb-free soldering	Criteria / test results
Wettability	IEC 60068-2-58	Immersion in 60/40 SnPb solder using non-activated flux at 215 ±3 °C for 3 ±0.3 s	Immersion in Sn96.5Ag3.0Cu0.5 solder using non- or low activated flux at 245 ±5 °C for 3 ±0.3 s	Covering of 95% of end termination, checked by visual inspection
Leaching resistance	IEC 60068-2-58	Immersion in 60/40 SnPb solder using mildly activated flux without preheating at 255 ±5 °C for 10 ±1 s	Immersion in Sn96.5Ag3.0Cu0.5 solder using non- or low activated flux without preheating at 255 ±5 °C for 10 ±1 s	No leaching of contacts
Tests of resistance to soldering heat for SMDs	IEC 60068-2-58	Immersion in 60/40 SnPb for 10 s at 260 °C	Immersion in Sn96.5Ag3.0Cu0.5 for 10 s at 260 °C	Capacitance change: $-15\% \leq \Delta C \leq 15\%$

Note:

Leaching of the termination

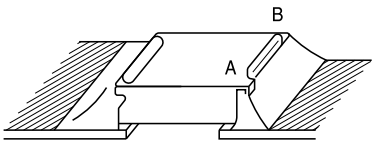
Effective area at the termination might be lost if the soldering temperature and/or immersion time are not kept within the recommended conditions. Leaching of the outer electrode should not exceed 25% of the chip end area (full length of the edge A-B-C-D) and 25% of the length A-B, shown below as mounted on the substrate.

As single chip



KKE0312-T-E

As mounted on substrate



KKE0313-2

5 Notes for proper soldering

5.1 Preheating and cooling

- The average ramp-up rate must not exceed 3 °C/s.
- The cooling rate must not exceed 8 °C/s.

5.2 Repair / rework

Manual soldering with a soldering iron must be avoided, hot-air methods are recommended for making repairs.

5.3 Cleaning

All environmentally compatible agents are suitable for cleaning. Select the appropriate cleaning solution according to the type of flux used. The temperature difference between the components and cleaning liquid must not be greater than 100 °C. Ultrasonic cleaning should be carried out with the utmost caution. Too high ultrasonic power can impair the adhesive strength of the metallized surfaces. Insufficient or excessive cleaning can be detrimental to CeraDiode performance.

5.4 Solder paste printing (reflow soldering)

An excessive application of solder paste results in too high a solder fillet, thus making the chip more susceptible to mechanical and thermal stress. This will lead to the formation of cracks. Too little solder paste reduces the adhesive strength on the outer electrodes and thus weakens the bonding to the PCB. The solder should be applied smoothly to the end surface to a height of min. 0.2 mm.

5.5 Selection of flux

Used flux should have less than or equal to 0.1 wt % of halogenated content, since flux residue after soldering could lead to corrosion of the termination and/or increased leakage current on the surface of the CeraDiode. Strong acidic flux must not be used. The amount of flux applied should be carefully controlled, since an excess may generate flux gas, which in turn is detrimental to solderability.

5.6 Storage

Solderability is guaranteed for one year from date of delivery, provided that components are stored in their original packages.

Storage temperature: −25 °C to +45 °C

Relative humidity: ≤75% annual average, ≤95% on 30 days a year

The solderability of the external electrodes may deteriorate if SMDs are stored where they are exposed to high humidity, dust or harmful gas (hydrogen chloride, sulfurous acid gas or hydrogen sulfide).

Do not store SMDs where they are exposed to heat or direct sunlight. Otherwise the packing material may be deformed or SMDs may stick together, causing problems during mounting.

After opening the factory seals, such as polyvinyl-sealed packages, it is recommended to use the SMDs as soon as possible.

SMD

5.7 Placement of components on circuit board

It is of advantage to place the components on the board before soldering so that their two terminals do not enter the solder oven at different times. Ideally, both terminals should be wetted simultaneously.

5.8 Soldering caution

- Sudden heating or cooling of the component results in thermal destruction by cracks.
- An excessively long soldering time or high soldering temperature results in leaching of the outer electrodes, causing poor adhesion due to loss of contact between electrodes and termination.
- Avoid manual soldering with a soldering iron.
- Wave soldering must not be applied for CeraDiodes designated for reflow soldering only.
- Keep to the recommended down-cooling rate.

5.9 Standards

CECC 00802
IEC 60068-2-58
IEC 60068-2-20
JEDEC J-STD-020D

CeraDiodes

High-speed series

SMD

Symbols and terms

CeraDiode	Semiconductor diode	
C_{max}		Maximum capacitance
C_{typ}		Typical capacitance
I_{BR}	I_R, I_T	(Reverse) current @ breakdown voltage
I_{leak}	I_{RM}	(Reverse) leakage current
I_{PP}	I_P, I_{PP}	Current @ clamping voltage, peak pulse current
P_{PP}	P_{PP}	Peak pulse power
T_{op}		Operating temperature
T_{stg}		Storage temperature
V_{BR}	V_{BR}	(Reverse) breakdown voltage
$V_{BR,min}$		Minimum breakdown voltage
V_{clamp}	$V_{cl,}$ V_C	Clamping voltage
$V_{clamp,max}$		Maximum clamping voltage
V_{DC}	V_{RM}, V_{RWM}, V_{WM}, V_{DC}	(Reverse) stand-off voltage, working voltage, operating voltage
$V_{DC,max}$		Maximum DC operating voltage
$V_{ESD,air}$		Air discharge ESD capability
$V_{ESD,contact}$		Contact discharge ESD capability
V_{leak}	V_{RM}, V_{RWM}, V_{WM}, V_{DC}	(Reverse) voltage @ leakage current
- *)	I_F	Current @ forward voltage
- *)	I_{RM}, $I_{RM,max}$@V_{RM}	(Reverse) current @ maximum reverse stand-off voltage, working voltage, operating voltage
- *)	V_F	Forward voltage

*) Not applicable due to bidirectional characteristics of CeraDiodes

SMD

Cautions and warnings

General

Some parts of this publication contain statements about the suitability of our CeraDiodes for certain areas of application, including recommendations about incorporation/design-in of these products into customer applications. The statements are based on our knowledge of typical requirements often made of our CeraDiodes in the particular areas. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our CeraDiodes for a particular customer application. As a rule, EPCOS is either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always incumbent on the customer to check and decide whether the CeraDiodes with the properties described in the product specification are suitable for use in a particular customer application.

- Do not use EPCOS CeraDiodes for purposes not identified in our specifications, application notes and data books.
- Ensure the suitability of a CeraDiode in particular by testing it for reliability during design-in. Always evaluate a CeraDiode under worst-case conditions.
- Pay special attention to the reliability of CeraDiodes intended for use in safety-critical applications (e.g. medical equipment, automotive, spacecraft, nuclear power plant).

Design notes

- Always connect a CeraDiode in parallel with the electronic circuit to be protected.
- Consider maximum rated power dissipation if a CeraDiode has insufficient time to cool down between a number of pulses occurring within a specified isolated time period. Ensure that electrical characteristics do not degrade.
- Consider derating at higher operating temperatures. Choose the highest voltage class compatible with derating at higher temperatures.
- Surge currents beyond specified values will puncture a CeraDiode. In extreme cases a CeraDiode will burst.
- If steep surge current edges are to be expected, make sure your design is as low-inductance as possible.
- In some cases the malfunctioning of passive electronic components or failure before the end of their service life cannot be completely ruled out in the current state of the art, even if they are operated as specified. Do not use CeraDiodes in applications requiring a very high level of operational safety and especially when the malfunction or failure of a passive electronic component could endanger human life or health (e.g. in accident prevention, life-saving systems, or automotive battery line applications such as clamp 30), ensure by suitable design of the application or other measures (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of such a malfunction or failure.
- Specified values only apply to CeraDiodes that have not been subject to prior electrical, mechanical or thermal damage. The use of CeraDiodes in line-to-ground applications is therefore not advisable, and it is only allowed together with safety countermeasures like thermal fuses.

CeraDiodes

High-speed series

SMD

Storage

- Only store CeraDiodes in their original packaging. Do not open the package before storage.
- Storage conditions in original packaging: temperature -25 to +45°C, relative humidity ≤75% annual average, maximum 95%, dew precipitation is inadmissible.
- Do not store CeraDiodes where they are exposed to heat or direct sunlight. Otherwise the packaging material may be deformed or CeraDiodes may stick together, causing problems during mounting.
- Avoid contamination of the CeraDiode surface during storage, handling and processing.
- Avoid storing CeraDiodes in harmful environments where they are exposed to corrosive gases for example (SO_x, Cl).
- Use CeraDiodes as soon as possible after opening factory seals such as polyvinyl-sealed packages.
- Solder CeraDiodes after shipment from EPCOS within the time specified: 12 months.

Handling

- Do not drop CeraDiodes and allow them to be chipped.
- Do not touch CeraDiodes with your bare hands - gloves are recommended.
- Avoid contamination of the CeraDiode surface during handling.
- Washing processes may damage the product due to the possible static or cyclic mechanical loads (e.g. ultrasonic cleaning). They may cause cracks to develop on the product and its parts, which might lead to reduced reliability or lifetime.

Mounting

- When CeraDiodes are encapsulated with sealing material or overmolded with plastic material, be aware that potting, sealing or adhesive compounds can produce chemical reactions in the CeraDiode ceramic that will degrade its electrical characteristics and reduce its lifetime.
- Make sure an electrode is not scratched before, during or after the mounting process.
- Make sure contacts and housings used for assembly with CeraDiodes are clean before mounting.
- The surface temperature of an operating CeraDiode can be higher. Ensure that adjacent components are placed at a sufficient distance from a CeraDiode to allow proper cooling.
- Avoid contamination of the CeraDiode surface during processing.
- Only CeraDiodes with an Ni barrier termination are approved for lead-free soldering.

Soldering

- Complete removal of flux is recommended to avoid surface contamination that can result in an instable and/or high leakage current.
- Use resin-type or non-activated flux.
- Bear in mind that insufficient preheating may cause ceramic cracks.
- Rapid cooling by dipping in solvent is not recommended, otherwise a component may crack.

SMD

Operation

- Use CeraDiodes only within the specified operating temperature range.
- Use CeraDiodes only within specified voltage and current ranges.
- Environmental conditions must not harm a CeraDiode. Only use them in normal atmospheric conditions. Reducing the atmosphere (e.g. hydrogen or nitrogen atmosphere) is prohibited.
- Prevent a CeraDiode from contacting liquids and solvents. Make sure that no water enters a CeraDiode (e.g. through plug terminals).
- Avoid dewing and condensation.
- EPCOS CeraDiodes are designed for encased applications. Under all circumstances avoid exposure to:
  - direct sunlight
  - rain or condensation
  - steam, saline spray
  - corrosive gases
  - atmosphere with reduced oxygen content
- EPCOS CeraDiodes are not suitable for switching applications or voltage stabilization where static power dissipation is required.

This listing does not claim to be complete, it merely reflects the experience of EPCOS AG.

Display of ordering codes for EPCOS products

The ordering code for one and the same EPCOS product can be represented differently in data sheets, data books, other publications, on the EPCOS website, or in order-related documents such as shipping notes, order confirmations and product labels. **The varying representations of the ordering codes are due to different processes employed and do not affect the specifications of the respective products**. Detailed information can be found on the Internet under www.epcos.com/orderingcodes

Important notes

The following applies to all products named in this publication:

1. Some parts of this publication contain **statements about the suitability of our products for certain areas of application**. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out **that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application**. As a rule, EPCOS is either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether an EPCOS product with the properties described in the product specification is suitable for use in a particular customer application.
2. We also point out that **in individual cases, a malfunction of electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified**. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of an electronic component could endanger human life or health (e.g. in accident prevention or lifesaving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of an electronic component.
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Important notes

7. The trade names EPCOS, Alu-X, CeraDiode, CeraLink, CeraPad, CeraPlas, CSMP, CSSP, CTVS, DeltaCap, DigiSiMic, DSSP, ExoCore, FilterCap, FormFit, LeaXield, MiniBlue, MiniCell, MKD, MKK, MotorCap, PCC, PhaseCap, PhaseCube, PhaseMod, PhiCap, PQSine, SIFERRIT, SIFI, SIKOREL, SilverCap, SIMDAD, SiMic, SIMID, SineFormer, SIOV, SIP5D, SIP5K, TFAP, ThermoFuse, WindCap are **trademarks registered or pending** in Europe and in other countries. Further information will be found on the Internet at www.epcos.com/trademarks.

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